

## Stein Variational Gradient Descent main ideas

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#### 1 Goal

Given a smooth density  $\pi$  supported on  $\mathcal{X} \subseteq \mathbb{R}^d$ , find  $\mu$  on  $\mathcal{X}$  as close as possible to  $\pi$ .

#### 2 Stein framework

Stein identity: Let  $A_{\pi}$  a Stein operator s.t.

$$\mathcal{A}_{\pi}\phi = \nabla \log \pi(\cdot)^{\top}\phi(\cdot) + \nabla \cdot \phi(\cdot)$$

with  $\phi(x) = [\phi_1(x), ..., \phi_d(x)]^{\top}$ . Then, if  $\phi$  is in the Stein class f  $\pi$  i.e.  $\phi(x)\pi(x) = 0$  for all  $x \in \partial \mathcal{X}$  if  $\mathcal{X}$  is compact or  $\lim_{\|x\| \to \infty} \phi(x)\pi(x) = 0$  if  $\mathcal{X} = \mathbb{R}^d$ , we have:

$$\mathbb{E}_{x \sim \pi}[\mathcal{A}_{\pi}\phi(x)] = 0 \tag{1}$$

Proof.

$$\mathbb{E}_{x \sim \pi}[\mathcal{A}_{\pi}\phi(x)] = \int_{\mathcal{X}} (\nabla \log \pi(\cdot)^{\top} \phi(\cdot) + \nabla \cdot \phi(\cdot)) \pi(x) dx$$

$$= \int_{\mathcal{X}} \nabla \log \pi(\cdot)^{\top} \phi(\cdot) \pi(x) dx + \int_{\mathcal{X}} \sum_{k=1}^{d} \frac{\partial \phi_{k}}{\partial x_{k}} \pi(x) dx$$

$$= \int_{\mathcal{X}} \nabla \log \pi(\cdot)^{\top} \phi(\cdot) \pi(x) dx + \int_{\mathcal{X}} \sum_{k=1}^{d} \frac{\partial \phi_{k}}{\partial x_{k}} \pi(x) dx$$

$$= \int_{\mathcal{X}} \nabla \log \pi(\cdot)^{\top} \phi(\cdot) \pi(x) dx + \sum_{k=1}^{d} \left( [\pi(x) \phi_{k}(x)]_{\mathcal{X}} - \int_{\mathcal{X}} \frac{\partial \pi(x)}{\partial x_{k}} \phi_{k}(x) dx \right)$$

$$= \int_{\mathcal{X}} \nabla \log \pi(\cdot)^{\top} \phi(\cdot) \pi(x) dx - \int_{\mathcal{X}} \sum_{k=1}^{d} \frac{\partial \pi(x)}{\partial x_{k}} \phi_{k}(x) dx$$

$$= \int_{\mathcal{X}} \pi(x) \sum_{k=1}^{d} \frac{\partial \log \pi(x)}{\partial x_{k}} \phi_{k}(x) - \pi(x) \sum_{k=1}^{d} \frac{\partial \log \pi(x)}{\partial x_{k}} \phi_{k}(x) dx \text{ (log trick)}$$

$$= 0$$

Now, let  $\mu$  a smooth density supported on  $\mathcal{X}$  different from  $\pi$ . Now, Eq. 1 do not hold anymore with  $x \sim \mu$ . However, we can use  $\mathbb{E}_{x \sim \mu}[\mathcal{A}_{\pi}\phi(x)]$  as a discrepancy measure between  $\mu$  and  $\pi$ , as its magnitude relates to how different  $\mu$  and  $\pi$  are (see Liu and Wang [2016] & Liu [2017]). Indeed, if we assume  $\phi$  to be in the Stein class of  $\mu$  as well (this is mild condition as  $\pi$  and  $\mu$  are two densities on  $\mathcal{X}$ , one can choose  $\phi$  to be in the Stein class of all distribution on  $\mathcal{X}$ . E.g. if  $\mathcal{X} = \mathbb{R}^d$ , one can pick

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 $\phi(x) = \exp[-\|x - y\|^2]$ ), we have:

$$\mathbb{E}_{x \sim \mu}[\mathcal{A}_{\pi}\phi(x)] = \int_{\mathcal{X}} \left( \nabla \log \pi(x)^{\top} \phi(x) + \nabla \cdot \phi(x) \right) \mu(x) dx$$

$$= \int_{\mathcal{X}} \nabla \log \pi(x)^{\top} \phi(x) \mu(x) dx + \sum_{k=1}^{d} \left( \left[ \mu(x) \phi_{k}(x) \right]_{\mathcal{X}} - \int_{\mathcal{X}} \frac{\partial \mu(x)}{\partial x_{k}} \phi_{k}(x) dx \right)$$

$$= \int_{\mathcal{X}} \mu(x) \sum_{k=1}^{d} \frac{\partial \log \pi(x)}{\partial x_{k}} \phi_{k}(x) - \mu(x) \sum_{k=1}^{d} \frac{\partial \log \mu(x)}{\partial x_{k}} \phi_{k}(x) dx \text{ (log trick)}$$

$$= \int_{\mathcal{X}} \mu(x) \left[ \sum_{k=1}^{d} \phi_{k}(x) \left( \frac{\partial \log \pi(x)}{\partial x_{k}} - \frac{\partial \log \mu(x)}{\partial x_{k}} \right) \right] dx$$

$$= \int_{\mathcal{X}} \mu(x) \left[ \sum_{k=1}^{d} \phi_{k}(x) \left( \frac{\partial \log \frac{\pi(x)}{\mu(x)}}{\partial x_{k}} \right) \right] dx.$$

$$(2)$$

As expected, the scale of  $\mathbb{E}_{x \sim \mu}[\mathcal{A}_{\pi}\phi(x)]$  increases with the distance between  $\mu$  and  $\pi$ .

Therefore, one can define an objective to find a density  $\mu^*$  close to  $\pi$ :

$$\mu^* = \arg\min_{\mu} \mathbb{S}(\mu, \pi) = \arg\min_{\mu} \max_{\phi \in \mathcal{H}} \{ \mathbb{E}_{x \sim \mu}[\mathcal{A}_{\pi} \phi(x)] \}, \tag{3}$$

as  $\mathbb{S}(\mu, \pi) = 0$  iff  $\mu = \pi$  and  $\mathbb{S}(\mu, \pi) > 0$  otherwise with  $\mathcal{H}$  sufficiently large. The choice of  $\mathcal{H}$  is therefore crucial. One way to ensure it is both rich enough and computationally tractable is to let  $\mathcal{H}$  be a RKHS.

#### 2.1 Kernelized Stein Discrepancy

Let  $\mathcal{H}_0$  be a RKHS with a kernel k(x, x') in the Stein class of  $\pi$  and  $\mu$ . Let  $\mathcal{H} = (\mathcal{H}_0^{(1)}, \dots, \mathcal{H}_0^{(d)})$ . The KSD maximizes  $\phi$  in the unit ball of  $\mathcal{H}$ . The objective in (3) is then:

$$\mathbb{S}(\mu, \pi) = \max_{\phi \in \mathcal{H}} \{ \mathbb{E}_{x \sim \mu} [\mathcal{A}_{\pi} \phi(x)], \ s.t. \ \|\phi\|_{\mathcal{H}} \le 1 \}. \tag{4}$$

Within this framework, one can show that the optimal solution of (4) (see [Liu et al., 2016, Oates et al., 2014, Chwialkowski et al., 2016]) is:

$$\phi(x) = \frac{\phi^*(x)}{\|\phi^*\|_{\mathcal{H}}}, \text{ where } \phi^*(.) = \mathbb{E}_{x \sim \mu}[\mathcal{A}_{\pi} \otimes k(x, \cdot)] = \int_{\mathcal{X}} k(x, \cdot) \nabla \log \pi(x) + \nabla k(x, \cdot) d\mu(x),$$
 (5)

where  $\mathcal{A}_{\pi} \otimes f(x) = f(x) \nabla \log \pi(x) + \nabla f(x)$ , is a variant of Stein operator <sup>1</sup>. Moreover,  $\mathbb{S}(\mu, \pi) = \|\phi^*\|_{\mathcal{H}}$ .

#### 3 Link with Kullback-Leibler Divergence

Let  $T: \mathcal{X} \to \mathcal{X}$ ,  $x \mapsto (I + \gamma \phi)(x)$ . One can show that (see Liu and Wang [2016] Theorem 3.1):

$$\nabla_{\gamma} K L(T_{\#}\mu||\pi) = -\mathbb{E}_{x \sim \mu} [\mathcal{A}_{\pi} \phi(x)]. \tag{6}$$

Therefore, using (5), we know that:

$$\phi^*(.) = \int_{\mathcal{X}} k(x, \cdot) \nabla \log \pi(x) + \nabla k(x, \cdot) d\mu(x)$$
 (7)

<sup>&</sup>lt;sup>1</sup> J'ai fait la preuve sur papier, je l'écrirai plus tard.

minimizes the  $\nabla_{\gamma} KL(T_{\#}\mu||\pi)$ . Furthermore, assuming RKHSes  $\mathcal{H}$  and  $\mathcal{H}_0$  with kernel k(x, x') in the Stein class of  $\pi$  and  $\mu$ , one can show that:

$$P_{\mu}\nabla\log\frac{\mu}{\pi}(\cdot) = \int_{\mathcal{X}} k(x,\cdot)\nabla\log\mu(x)d\mu(x) - \int_{\mathcal{X}} k(x,\cdot)\nabla\log\pi(x)d\mu(x)$$

$$= \int_{\mathcal{X}} k(x,\cdot)\nabla\mu(x)dx - \int_{\mathcal{X}} k(x,\cdot)\nabla\log\pi(x)d\mu(x)$$

$$= -\int_{\mathcal{X}} \nabla k(x,\cdot)d\mu(x) - \int_{\mathcal{X}} k(x,\cdot)\nabla\log\pi(x)d\mu(x)$$

$$= -\int_{\mathcal{X}} k(x,\cdot)\nabla\log\pi(x) + \nabla k(x,\cdot)d\mu(x)$$

$$= -\phi^*(\cdot)$$
(8)

The Stein Variational Gradient Descent (SVGD) algorithm consists in an iterative procedure where one apply successive transformations to an initial density  $\mu_0$  towards the "direction"  $\phi^*$  that minimizes the gradient of the Kullback-Leibler divergence:

$$\mu_{n+1} = (I + \gamma \phi^*)_{\#} \mu_n = \left(I - \gamma P_{\mu} \nabla \log \frac{\mu}{\pi}\right)_{\#} \mu_n.$$
 (9)

### 4 Not understood yet

- $-k(x,\cdot)$  in the Stein class of  $\pi$  and  $\mu$ ?
- Link with Wasserstein distance?
- Why did they defined so much about their RKHS?

# **Bibliography**

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